## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SHU ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,006,453	02-2006	Ahmed et al.	370/255
*	В	US-2004/0219909	11-2004	Kennedy et al.	455/422.1
*	С	US-2005/0076054	04-2005	Moon et al.	707/103.00Y
*	D	US-6,977,938	12-2005	Alriksson et al.	370/401
*	Ε	US-5,974,236	10-1999	Sherman, Michael J.	709/221
*	F	US-2004/0218582	11-2004	Kennedy et al.	370/351
*	G	US-7,031,321	04-2006	Habetha, Joerg	370/395.31
*	Н	US-2002/0062388	05-2002	Ogier et al.	709/238
*	ı	US-2004/0160943	08-2004	Cain, Joseph Bibb	370/351
*	J	US-2005/0129000	06-2005	Sivakumar et al.	370/351
	К	US-			
	L	US-			
	M	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q		,			
	R					
	S			·		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U.								
	<b>V</b>								
	w								
	x								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.